

<b>Search Notes</b>	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10786164	BEAN ET AL.
<b>Examiner</b>	Art Unit	
Chin-Shue, Alvin C	3634	

### SEARCHED

Class	Subclass	Date	Examiner
182	18	4/27/07	acs
update		10/10/07	acs
update		7/9/08	acs
182	2.8, 2.9, 18	8/2/11	acs

### SEARCH NOTES

Search Notes	Date	Examiner

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
182	2.8, 2.9, 18	8/2/11	acs

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